

**IAP20 Rec'd PGT/PTO 27 JAN 2006**  
**PATENT**

**IN THE UNITED STATES PATENT OFFICE**

Serial No.: Not yet assigned

Filed: Herewith

For: **DEVICE AND METHOD FOR  
ELECTROLYTICALLY TREATING  
ELECTRICALLY INSULATED STRUCTURES**

Inventor(s): Michael Guggemos and Franz Kohnle

Based on: PCT/EP2004/009436, dated August 19, 2004

Priority: DE 10342512.8, dated September 12, 2003

Atty Doc. No.: 366-05

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**INFORMATION DISCLOSURE STATEMENT**

*Commissioner for Patents*  
*P.O. Box 1450*  
*Alexandria, VA 22313-1450*

Sir:

In the interest of full disclosure, the following items are herewith identified in Form PTO-1449 and a copy of the same is hereby provided, for the convenience of the U.S. Patent and Trademark Office.

This Information Disclosure Statement is being filed before the mailing date of the first official action.

**U.S. PATENT DOCUMENTS**

(AA) 4,560,445, dated December 24, 1985.

(AB) 5,188,720, dated February 23, 1993.

(AC) 5,425,862, dated June 20, 1995

(AD) 6,071,400, dated June 6, 2000.

IAP20H384PCW10 27 JAN 2006

U.S. PATENT APPLICATION PUBLICATIONS

(AE) 6,309,517 B1, dated October 10, 2001.

FOREIGN PATENT DOCUMENTS

(AF) DE 100 43 814 C1, dated April 11, 2002. Relevance was cited a category "Y" in the International Search Report.

(AG) DE 100 65 643 C2, dated March 20, 2003. Relevance is cited on page two (2) of the application.

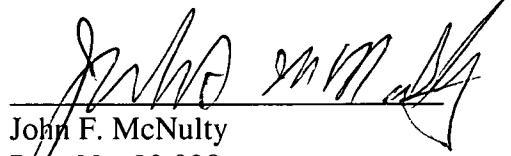
(AH) DE 100 65 649 A1, dated July 11, 2002. Relevance is cited on page three (3) of the application.

(AI) DE 199 51 325 A1, dated May 10, 2001. Relevance is cited as a category "A" in the International Search Report, enclosed herewith.

(AJ) DE 199 51 325 C2, dated June 26, 2003. Relevance is cited on page two (2) of the application.

(AK) WO 03/038158 A2, dated May 8, 2003. Relevance is cited on page two (2) of the application.

Respectfully submitted,

  
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Receipt date: 01/27/2006

Docket Number (Optional)

366-05

Application Number GAU: 1795

## INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Applicant(s)

Michael Guggemos and Franz Kohnle

Filing Date

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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	4,560,445	12-24-1985	Hoover et al.			
	AB	5,188,720	02-23-1993	Colin et al.			
	AC	5,425,862	06-20-1995	Hartmann et al.			
	AD	6,071,400	06-06-2000	Shroder et al.			

## U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AE	6,309,517 B1	10-30-2001	Condra et al.			

## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
	AE	DE 100 43 814 C1	4-11-2002	GERMANY				
	AG	DE 100 65 643 C2	3-20-2003	GERMANY				
	AH	DE 100 65 649 A1	7-11-2002	GERMANY				
	AI	DE 199 51 325 A1	5-10-2001	GERMANY				
	AJ	DE 199 51 325 C2	6-26-2003	GERMANY				

## OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Receipt date: 01/27/2006

**INFORMATION DISCLOSURE CITATION**

(Use several sheets if necessary)

Docket Number (Optional)

366-05

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Applicant(s)

Michael Gu... and Franz Kohnle

Filing Date

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Group Art Unit

07 JAN 2006  
NA

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

**U.S. PATENT APPLICATION PUBLICATIONS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

**FOREIGN PATENT DOCUMENTS**

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
	AK	WO 03/038158 A2	05-08-2003	INTERNATIONAL				

**OTHER DOCUMENTS**

(Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

/Luan Van/ (06/10/2009)

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